

**Notice of References Cited**

Application/Control No.

10/613,102

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Jennifer M. Kennedy

Art Unit

2812

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6602721	08-2003	Mikawa et al.	438/3
	B	US-5786259	07-1998	Kang	438/396
	C	US-6333534	12-2001	Chen	257/303
	D	US-6376325	04-2002	Koo	438/396
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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	X	

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*J. Kennedy 7/15/04*